

# X5328, X5329

CPU Supervisor with 32Kbit SPI EEPROM

FN8132  
Rev 3.00  
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The [X5328](#) and [X5329](#) devices combine three popular functions, Power-on Reset Control, Supply Voltage Supervision, and Block Lock Protect Serial EEPROM Memory in one package. This combination lowers system cost, reduces board space requirements, and increases reliability.

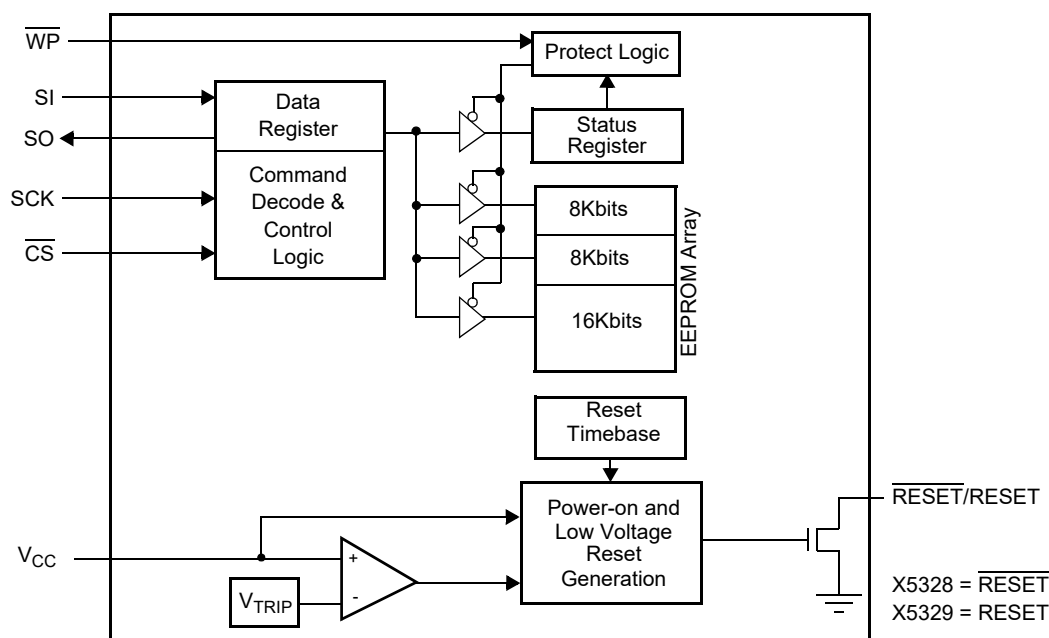
Applying power to the device activates the power-on reset circuit which holds RESET/RESET active for a period of time. This allows the power supply and oscillator to stabilize before the processor can execute code.

The device's low  $V_{CC}$  detection circuitry protects the user's system from low voltage conditions by holding RESET/RESET active when  $V_{CC}$  falls below a minimum  $V_{CC}$  trip point. RESET/RESET remains asserted until  $V_{CC}$  returns to proper operating level and stabilizes. Five industry standard  $V_{TRIP}$  thresholds are available, however, the unique circuits allow the threshold to be reprogrammed to meet custom requirements or to fine-tune the threshold in applications requiring higher precision.

## FEATURES

- **Low  $V_{CC}$  detection and reset assertion**
  - Five standard reset threshold voltages
  - Re-program low  $V_{CC}$  reset threshold voltage using special programming sequence
  - Reset signal valid to  $V_{CC} = 1V$
- **Long battery life with low power consumption**
  - $<1\mu A$  max standby current
  - $<400\mu A$  max active current during read
- **32Kbits of EEPROM**
- **Built-in inadvertent write protection**
  - Power-up/power-down protection circuitry
  - Protect 0, 1/4, 1/2 or all of EEPROM array with Block Lock™ protection
  - In circuit programmable ROM mode
- **2MHz SPI interface modes (0,0 & 1,1)**
- **Minimize EEPROM programming time**
  - 32-byte page write mode
  - Self-timed write cycle
  - 5ms write cycle time (typical)
- **2.7V to 5.5V and 4.5V to 5.5V power supply operation**
- **Available packages**
  - 8 Ld SOIC
- **Pb-free plus anneal available (RoHS compliant)**

## BLOCK DIAGRAM



## Ordering Information

| PART NUMBER<br>(Notes 2, 3) | PART<br>MARKING | V <sub>CC</sub><br>RANGE (V) | V <sub>TRIP</sub><br>RANGE (V) | PACKAGE DESCRIPTION<br>(RoHS Compliant) | PKG.<br>DWG # | Carrier Type<br>(Note 1) | TEMP<br>RANGE (°C) |            |             |            |             |
|-----------------------------|-----------------|------------------------------|--------------------------------|-----------------------------------------|---------------|--------------------------|--------------------|------------|-------------|------------|-------------|
| RESET ACTIVE LOW            |                 |                              |                                |                                         |               |                          |                    |            |             |            |             |
| X5328S8Z-4.5A               | X5328<br>ZAL    | 4.5-5.5                      | 4.5-4.75                       | 8 Ld SOIC                               | M8.15E        | Tube                     | 0 to 70°C          |            |             |            |             |
| X5328S8IZ-4.5A              | X5328<br>ZAM    |                              |                                |                                         |               |                          | -40 to 85°C        |            |             |            |             |
| X5328S8Z                    | X5328<br>Z      | 4.5-5.5                      | 4.25-4.5                       |                                         |               | Tube                     | 0 to 70°C          |            |             |            |             |
| X5328S8ZT1                  |                 |                              |                                |                                         |               | Reel, 2.5k               |                    |            |             |            |             |
| X5328S8IZ                   | X5328<br>ZI     |                              |                                |                                         |               | Tube                     | -40 to 85°C        |            |             |            |             |
| X5328S8IZT1                 |                 |                              |                                |                                         |               | Reel, 2.5k               |                    |            |             |            |             |
| X5328S8Z-2.7A               | X5328<br>ZAN    | 2.7-5.5                      | 2.85-3.0                       |                                         |               | 8 Ld SOIC                | M8.15E             | Tube       | 0 to 70°C   |            |             |
| X5328S8IZ-2.7A              | X5328<br>ZAP    |                              |                                |                                         |               |                          |                    |            | -40 to 85°C |            |             |
| X5328S8Z-2.7                | X5328<br>ZF     | 2.7-5.5                      | 2.55-2.7                       |                                         |               |                          |                    | Tube       | 0 to 70°C   |            |             |
| X5328S8Z-2.7T1              |                 |                              |                                |                                         |               |                          |                    | Reel, 2.5k | 0 to 70°C   |            |             |
| X5328S8IZ-2.7               | X5328<br>ZG     |                              |                                |                                         |               |                          |                    | Tube       | -40 to 85°C |            |             |
| X5328S8IZ-2.7T1             |                 |                              |                                |                                         |               |                          |                    | Reel, 2.5k | -40 to 85°C |            |             |
| RESET ACTIVE HIGH           |                 |                              |                                |                                         |               |                          |                    |            |             |            |             |
| X5329S8Z-4.5A               | X5329<br>ZAL    | 4.5-5.5                      | 4.5-4.75                       | 8 Ld SOIC                               | M8.15E        |                          |                    | Tube       | 0 to 70°C   |            |             |
| X5329S8IZ-4.5A              | X5329<br>ZAM    |                              |                                |                                         |               |                          |                    |            | -40 to 85°C |            |             |
| X5329S8Z                    | X5329<br>Z      | 4.5-5.5                      | 4.25-4.5                       |                                         |               |                          |                    | Tube       | 0 to 70°C   |            |             |
| X5329S8ZT1                  |                 |                              |                                |                                         |               |                          |                    | Reel, 2.5k | 0 to 70°C   |            |             |
| X5329S8IZ                   | X5329<br>ZI     |                              |                                |                                         |               |                          |                    | Tube       | -40 to 85°C |            |             |
| X5329S8IZT1                 |                 |                              |                                |                                         |               |                          |                    | Reel, 2.5k | -40 to 85°C |            |             |
| X5329S8Z-2.7A               | X5329<br>ZAN    | 2.7-5.5                      | 2.85-3.0                       |                                         |               | 8 Ld SOIC                | M8.15E             | Tube       | 0 to 70°C   |            |             |
| X5329S8Z-2.7                | X5329<br>ZF     |                              |                                |                                         |               |                          |                    |            | Tube        |            |             |
| X5329S8Z-2.7T1              |                 | Reel, 2.5k                   |                                |                                         |               |                          |                    |            |             |            |             |
| X5329S8IZ-2.7T1             | X5329<br>ZG     | 2.7-5.5                      | 2.55-2.7                       |                                         |               |                          |                    | 8 Ld SOIC  | M8.15E      | Reel, 2.5k | -40 to 85°C |

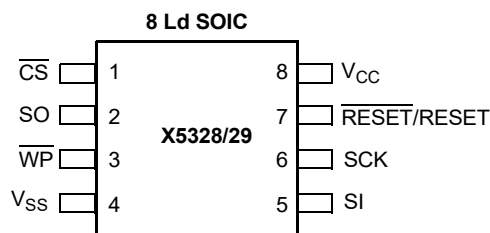
### NOTES:

1. See [TB347](#) for details about reel specifications.
2. These Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J-STD-020.
3. For Moisture Sensitivity Level (MSL), see the [X5328](#), [X5329](#) product pages. For more information about MSL, see TB363.

## PIN DESCRIPTION

| Pin Number | Name                                 | Function                                                                                                                                                                                                                                                                                                                                                                                                                                   |
|------------|--------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1          | $\overline{\text{CS}}$               | <b>Chip Select Input.</b> $\overline{\text{CS}}$ HIGH, deselects the device and the SO output pin is at a high impedance state. Unless a nonvolatile write cycle is underway, the device will be in the standby power mode. $\overline{\text{CS}}$ LOW enables the device, placing it in the active power mode. Prior to the start of any operation after power-up, a HIGH to LOW transition on $\overline{\text{CS}}$ is required.        |
| 2          | SO                                   | <b>Serial Output.</b> SO is a push/pull serial data output pin. A read cycle shifts data out on this pin. The falling edge of the serial clock (SCK) clocks the data out.                                                                                                                                                                                                                                                                  |
| 5          | SI                                   | <b>Serial Input.</b> SI is a serial data input pin. Input all opcodes, byte addresses, and memory data on this pin. The rising edge of the serial clock (SCK) latches the input data. Send all opcodes (Table 1), addresses and data MSB first.                                                                                                                                                                                            |
| 6          | SCK                                  | <b>Serial Clock.</b> The Serial Clock controls the serial bus timing for data input and output. The rising edge of SCK latches in the opcode, address, or data bits present on the SI pin. The falling edge of SCK changes the data output on the SO pin.                                                                                                                                                                                  |
| 3          | $\overline{\text{WP}}$               | <b>Write Protect.</b> The $\overline{\text{WP}}$ pin works in conjunction with a nonvolatile WPEN bit to “lock” the setting of the Watchdog Timer control and the memory write protect bits.                                                                                                                                                                                                                                               |
| 4          | $V_{\text{SS}}$                      | Ground                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| 8          | $V_{\text{CC}}$                      | Supply Voltage                                                                                                                                                                                                                                                                                                                                                                                                                             |
| 7          | $\overline{\text{RESET}}$ /<br>RESET | <b>Reset Output.</b> $\overline{\text{RESET}}$ /RESET is an active LOW/HIGH, open drain output which goes active whenever $V_{\text{CC}}$ falls below the minimum $V_{\text{CC}}$ sense level. It remains active until $V_{\text{CC}}$ rises above the minimum $V_{\text{CC}}$ sense level for 200ms. $\overline{\text{RESET}}$ /RESET goes active on power-up at about 1V and remains active for 200ms after the power supply stabilizes. |

## PIN CONFIGURATION



## PRINCIPLES OF OPERATION

### Power-On Reset

Application of power to the X5328/X5329 activates a Power-on Reset Circuit. This circuit goes active at about 1V and pulls the  $\overline{\text{RESET}}$ /RESET pin active. This signal prevents the system microprocessor from starting to operate with insufficient voltage or prior to stabilization of the oscillator. When  $V_{CC}$  exceeds the device  $V_{TRIP}$  value for 200ms (nominal) the circuit releases  $\overline{\text{RESET}}$ /RESET, allowing the processor to begin executing code.

### Low Voltage Monitoring

During operation, the X5328/X5329 monitors the  $V_{CC}$  level and asserts  $\overline{\text{RESET}}$ /RESET if supply voltage falls below a preset minimum  $V_{TRIP}$ . The  $\overline{\text{RESET}}$ /RESET signal prevents the microprocessor from operating in a power fail or brownout condition. The  $\overline{\text{RESET}}$ /RESET signal remains active until the voltage drops below 1V. It also remains active until  $V_{CC}$  returns and exceeds  $V_{TRIP}$  for 200ms.

### $V_{CC}$ Threshold Reset Procedure

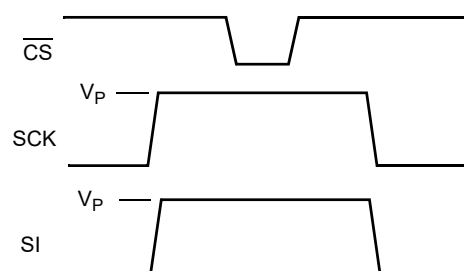
The X5328/X5329 has a standard  $V_{CC}$  threshold ( $V_{TRIP}$ ) voltage. This value will not change over normal operating and storage conditions. However, in applications where the standard  $V_{TRIP}$  is not exactly right, or for higher precision in the  $V_{TRIP}$  value, the X5328/X5329 threshold may be adjusted.

### Setting the $V_{TRIP}$ Voltage

This procedure sets the  $V_{TRIP}$  to a higher voltage value. For example, if the current  $V_{TRIP}$  is 4.4V and the new  $V_{TRIP}$  is 4.6V, this procedure directly makes the change. If the new setting is lower than the current setting, then it is necessary to reset the trip point before setting the new value.

To set the new  $V_{TRIP}$  voltage, apply the desired  $V_{TRIP}$  threshold to the  $V_{CC}$  pin and tie the  $\overline{\text{CS}}$  pin and the  $\overline{\text{WP}}$  pin HIGH.  $\overline{\text{RESET}}$ /RESET and SO pins are left unconnected. Then apply the programming voltage  $V_P$  to both SCK and SI and pulse  $\overline{\text{CS}}$  LOW then HIGH. Remove  $V_P$  and the sequence is complete.

Figure 1. Set  $V_{TRIP}$  Voltage

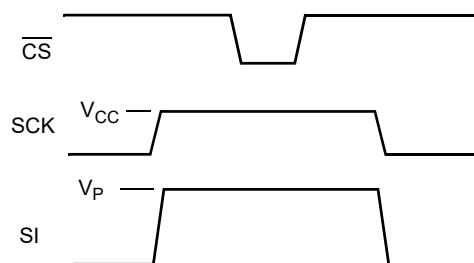


### Resetting the $V_{TRIP}$ Voltage

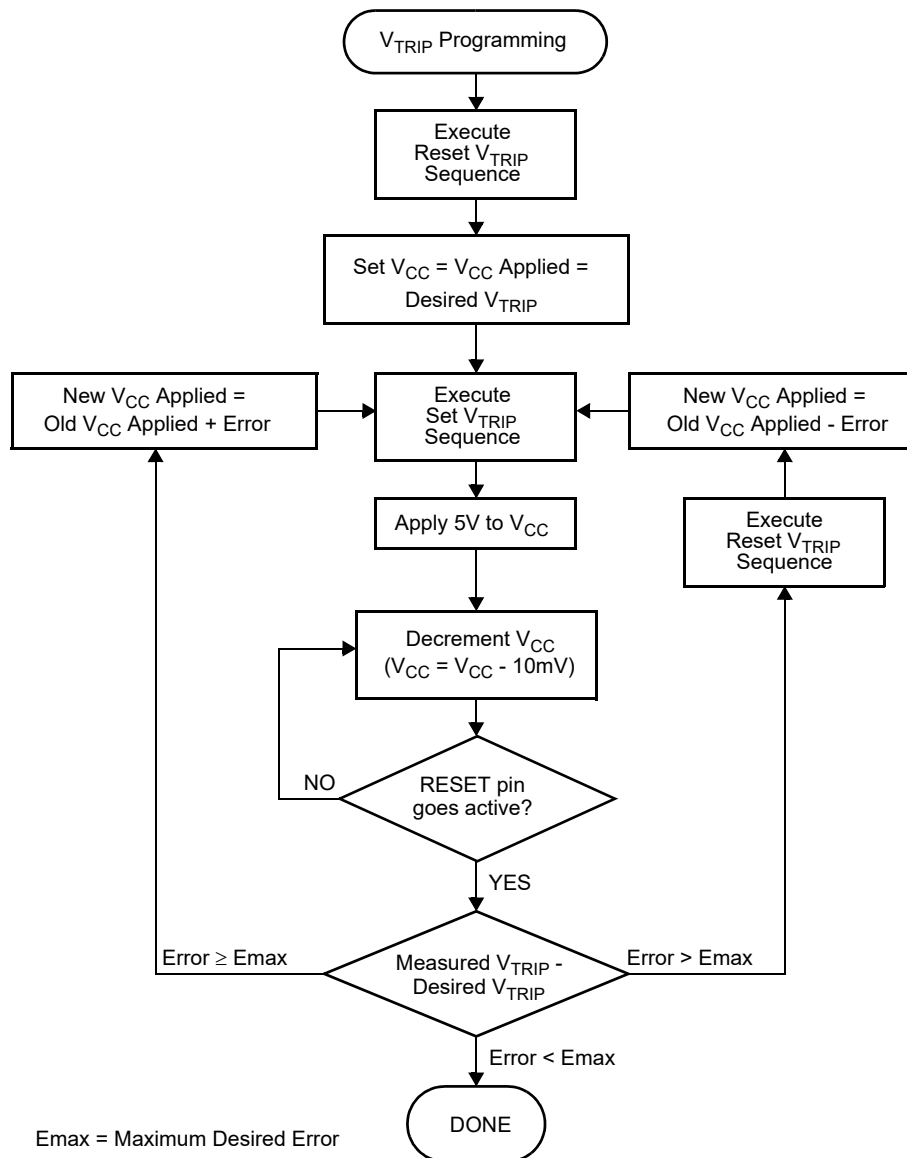
This procedure sets the  $V_{TRIP}$  to a "native" voltage level. For example, if the current  $V_{TRIP}$  is 4.4V and the  $V_{TRIP}$  is reset, the new  $V_{TRIP}$  is something less than 1.7V. This procedure must be used to set the voltage to a lower value.

To reset the  $V_{TRIP}$  voltage, apply a voltage between 2.7 and 5.5V to the  $V_{CC}$  pin. Tie the  $\overline{\text{CS}}$  pin, the  $\overline{\text{WP}}$  pin, and the SCK pin HIGH.  $\overline{\text{RESET}}$ /RESET and SO pins are left unconnected. Then apply the programming voltage  $V_P$  to the SI pin ONLY and pulse  $\overline{\text{CS}}$  LOW then HIGH. Remove  $V_P$  and the sequence is complete.

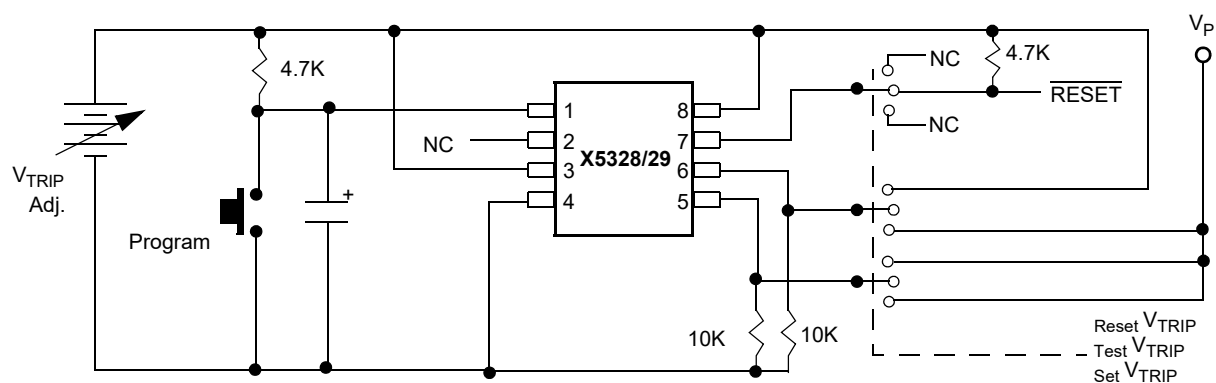
Figure 2. Reset  $V_{TRIP}$  Voltage



### Figure 3. V<sub>TRIP</sub> Programming Sequence Flow Chart



### Figure 4. Sample $V_{TRIP}$ Reset Circuit



## SPI SERIAL MEMORY

The memory portion of the device is a CMOS Serial EEPROM array with block lock protection. The array is internally organized as x 8. The device features a Serial Peripheral Interface (SPI) and software protocol allowing operation on a simple four-wire bus.

The device utilizes proprietary Direct Write™ cell, providing a minimum endurance of 100,000 cycles and a minimum data retention of 100 years.

The device is designed to interface directly with the synchronous Serial Peripheral Interface (SPI) of many popular microcontroller families. It contains an 8-bit instruction register that is accessed via the SI input, with data being clocked in on the rising edge of SCK.  $\overline{CS}$  must be LOW during the entire operation.

All instructions (Table 1), addresses and data are transferred MSB first. Data input on the SI line is latched on the first rising edge of SCK after  $\overline{CS}$  goes LOW. Data is output on the SO line by the falling edge of SCK. SCK is static, allowing the user to stop the clock and then start it again to resume operations where left off.

## Write Enable Latch

The device contains a Write Enable Latch. This latch must be SET before a Write Operation is initiated. The WREN instruction will set the latch and the WRDI instruction will reset the latch (Figure 3). This latch is automatically reset upon a power-up condition and after the completion of a valid Write Cycle.

## Status Register

The RDSR instruction provides access to the Status Register. The Status Register may be read at any time, even during a Write Cycle. The Status Register is formatted as follows:

| 7    | 6   | 5  | 4  | 3   | 2   | 1   | 0   |
|------|-----|----|----|-----|-----|-----|-----|
| WPEN | FLB | 1* | 1* | BL1 | BL0 | WEL | WIP |

\*Bits (5,4) should be written as '1' only.

The Write-In-Progress (WIP) bit is a volatile, read only bit and indicates whether the device is busy with an internal nonvolatile write operation. The WIP bit is read using the RDSR instruction. When set to a "1", a nonvolatile write operation is in progress. When set to a "0", no write is in progress.

**Table 1. Instruction Set**

| Instruction Name | Instruction Format* | Operation                                                 |
|------------------|---------------------|-----------------------------------------------------------|
| WREN             | 0000 0110           | Set the Write Enable Latch (Enable Write Operations)      |
| SFLB             | 0000 0000           | Set Flag Bit                                              |
| WRDI/RFLB        | 0000 0100           | Reset the Write Enable Latch/Reset Flag Bit               |
| RSDR             | 0000 0101           | Read Status Register                                      |
| WRSR             | 0000 0001           | Write Status Register (Block Lock, WPEN & Flag Bits)      |
| READ             | 0000 0011           | Read Data from Memory Array Beginning at Selected Address |
| WRITE            | 0000 0010           | Write Data to Memory Array Beginning at Selected Address  |

Note: \*Instructions are shown MSB in leftmost position. Instructions are transferred MSB first.

**Table 2. Block Protect Matrix**

| WREN CMD | Status Register | Device Pin | Block           | Block             | Status Register          |
|----------|-----------------|------------|-----------------|-------------------|--------------------------|
| WEL      | WPEN            | WP#        | Protected Block | Unprotected Block | WPEN, BL0, BL1, WD0, WD1 |
| 0        | X               | X          | Protected       | Protected         | Protected                |
| 1        | 1               | 0          | Protected       | Writable          | Protected                |
| 1        | 0               | X          | Protected       | Writable          | Writable                 |
| 1        | X               | 1          | Protected       | Writable          | Writable                 |

The Write Enable Latch (WEL) bit indicates the Status of the Write Enable Latch. When WEL = 1, the latch is set HIGH and when WEL = 0 the latch is reset LOW. The

WEL bit is a volatile, read only bit. It can be set by the WREN instruction and can be reset by the WRDS instruction.

The block lock bits, BL0 and BL1, set the level of block lock protection. These nonvolatile bits are programmed using the WRSR instruction and allow the user to protect one quarter, one half, all or none of the EEPROM array. Any portion of the array that is block lock protected can be read but not written. It will remain protected until the BL bits are altered to disable block lock protection of that portion of memory.

| Status Register Bits |     | Array Addresses Protected |
|----------------------|-----|---------------------------|
| BL1                  | BL0 | X5328/X5329               |
| 0                    | 0   | None                      |
| 0                    | 1   | \$0C00-\$0FFF             |
| 1                    | 0   | \$0800-\$0FFF             |
| 1                    | 1   | \$0000-\$0FFF             |

The FLAG bit shows the status of a volatile latch that can be set and reset by the system using the SFLB and RFLB instructions. The Flag bit is automatically reset upon power-up.

The nonvolatile WPEN bit is programmed using the WRSR instruction. This bit works in conjunction with the  $\overline{WP}$  pin to provide an In-Circuit Programmable ROM function (Table 2).  $\overline{WP}$  is LOW and WPEN bit programmed HIGH disables all Status Register Write Operations.

### In Circuit Programmable ROM Mode

This mechanism protects the block lock and Watchdog bits from inadvertent corruption.

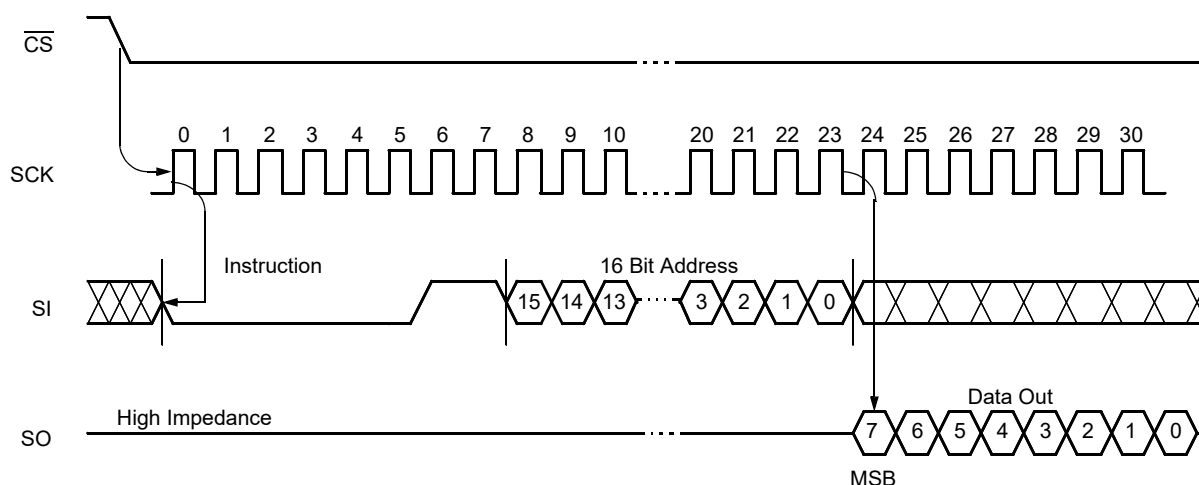
In the locked state (Programmable ROM Mode) the  $\overline{WP}$  pin is LOW and the nonvolatile bit WPEN is "1". This mode disables nonvolatile writes to the device's Status Register.

Setting the  $\overline{WP}$  pin LOW while WPEN is a "1" while an internal write cycle to the Status Register is in progress will not stop this write operation, but the operation disables subsequent write attempts to the Status Register.

When  $\overline{WP}$  is HIGH, all functions, including nonvolatile writes to the Status Register operate normally.

Setting the WPEN bit in the Status Register to "0" blocks the  $\overline{WP}$  pin function, allowing writes to the Status Register when  $\overline{WP}$  is HIGH or LOW. Setting the WPEN bit to "1" while the  $\overline{WP}$  pin is LOW activates the Programmable ROM mode, thus requiring a change in the  $\overline{WP}$  pin prior to subsequent Status Register changes. This allows manufacturing to install the device in a system with  $\overline{WP}$  pin grounded and still be able to program the Status Register. Manufacturing can then load Configuration data, manufacturing time and other parameters into the EEPROM, then set the portion of memory to be protected by setting the block lock bits, and finally set the "OTP mode" by setting the WPEN bit. Data changes now require a hardware change.

**Figure 5. Read EEPROM Array Sequence**



## Read Sequence

When reading from the EEPROM memory array,  $\overline{CS}$  is first pulled low to select the device. The 8-bit READ instruction is transmitted to the device, followed by the 16-bit address. After the READ opcode and address are sent, the data stored in the memory at the selected address is shifted out on the SO line. The data stored in memory at the next address can be read sequentially by continuing to provide clock pulses. The address is automatically incremented to the next higher address after each byte of data is shifted out. When the highest address is reached, the address counter rolls over to address \$0000 allowing the read cycle to be continued indefinitely. The read operation is terminated by taking  $\overline{CS}$  high. Refer to the Read EEPROM Array Sequence (Figure 1).

To read the Status Register, the  $\overline{CS}$  line is first pulled low to select the device followed by the 8-bit RDSR instruction. After the RDSR opcode is sent, the contents of the Status Register are shifted out on the SO line. Refer to the Read Status Register Sequence (Figure 2).

## Write Sequence

Prior to any attempt to write data into the device, the "Write Enable" Latch (WEL) must first be set by issuing the WREN instruction (Figure 3).  $\overline{CS}$  is first taken LOW, then the WREN instruction is clocked into the device. After all eight bits of the instruction are transmitted,  $\overline{CS}$  must then be taken HIGH. If the user continues the Write Operation without taking  $\overline{CS}$  HIGH after issuing the WREN instruction, the Write Operation will be ignored.

To write data to the EEPROM memory array, the user then issues the WRITE instruction followed by the 16-bit address and then the data to be written. Any unused address bits are specified to be "0's". The WRITE operation minimally takes 32 clocks.  $\overline{CS}$  must go low and remain low for the duration of the operation. If the address counter reaches the end of a page and the clock continues, the counter will roll back to the first address of the page and overwrite any data that may have been previously written.

For the Page Write Operation (byte or page write) to be completed,  $\overline{CS}$  can only be brought HIGH after bit 0 of the last data byte to be written is clocked in. If it is brought HIGH at any other time, the write operation will not be completed (Figure 4).

To write to the Status Register, the WRSR instruction is followed by the data to be written (Figure 5). Data bits 0 and 1 must be "0".

While the write is in progress following a Status Register or EEPROM Sequence, the Status Register may be read to check the WIP bit. During this time the WIP bit will be high.

## OPERATIONAL NOTES

The device powers-up in the following state:

- The device is in the low power standby state.
- A HIGH to LOW transition on  $\overline{CS}$  is required to enter an active state and receive an instruction.
- SO pin is high impedance.
- The Write Enable Latch is reset.
- The Flag Bit is reset.
- Reset Signal is active for  $t_{PURST}$ .

## Data Protection

The following circuitry has been included to prevent inadvertent writes:

- A WREN instruction must be issued to set the Write Enable Latch.
- $\overline{CS}$  must come HIGH at the proper clock count in order to start a nonvolatile write cycle.

Figure 6. Read Status Register Sequence

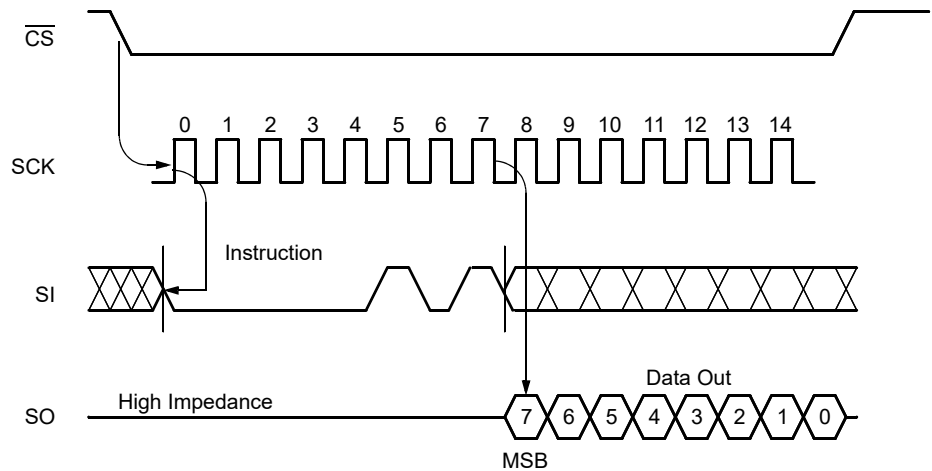


Figure 7. Write Enable Latch Sequence

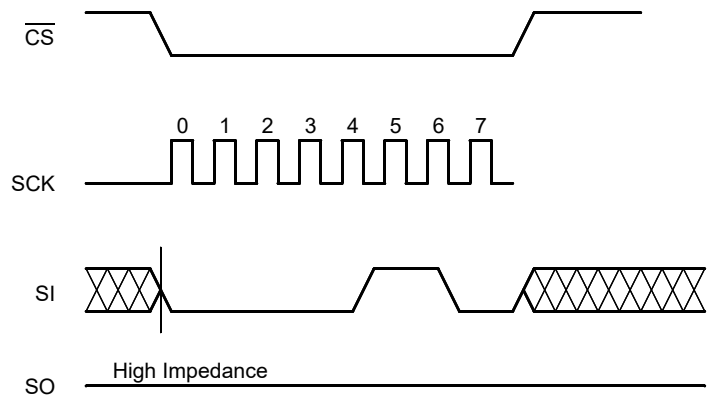


Figure 8. Write Sequence

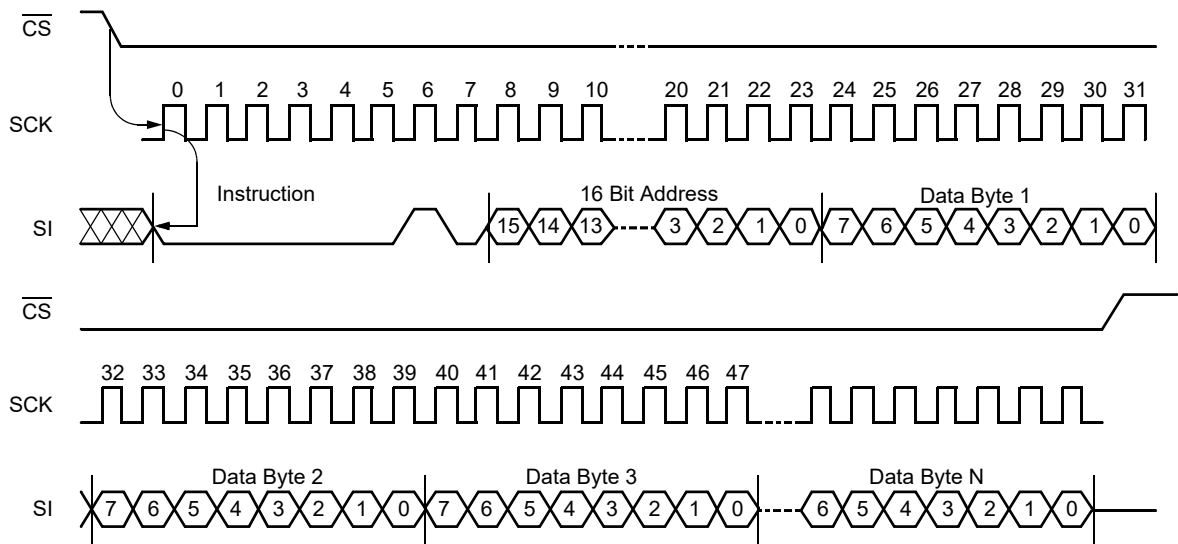
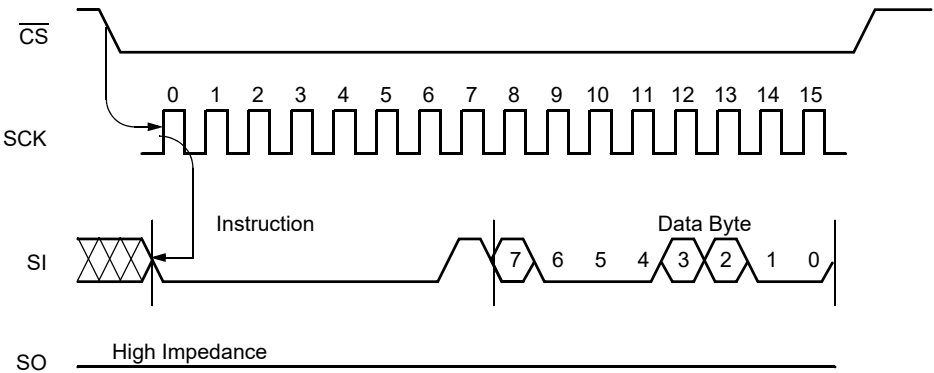


Figure 9. Status Register Write Sequence



SYMBOL TABLE

| WAVEFORM | INPUTS                      | OUTPUTS                       |
|----------|-----------------------------|-------------------------------|
|          | Must be steady              | Will be steady                |
|          | May change from LOW to HIGH | Will change from LOW to HIGH  |
|          | May change from HIGH to LOW | Will change from HIGH to LOW  |
|          | Don't Care: Changes Allowed | Changing: State Not Known     |
|          | N/A                         | Center Line is High Impedance |

**ABSOLUTE MAXIMUM RATINGS**

Temperature under bias ..... -65°C to +135°C  
 Storage temperature ..... -65°C to +150°C  
 Voltage on any pin with  
   respect to  $V_{SS}$  ..... -1.0V to +7V  
 D.C. output current ..... 5mA  
 Lead temperature (soldering, 10s) ..... 300°C

**COMMENT**

Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only; functional operation of the device (at these or any other conditions above those listed in the operational sections of this specification) is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**RECOMMENDED OPERATING CONDITIONS**

| Temperature | Min.  | Max.  |
|-------------|-------|-------|
| Commercial  | 0°C   | 70°C  |
| Industrial  | -40°C | +85°C |

| Voltage Option | Supply Voltage |
|----------------|----------------|
| -2.7 or -2.7A  | 2.7V to 5.5V   |
| Blank or -4.5A | 4.5V-5.5V      |

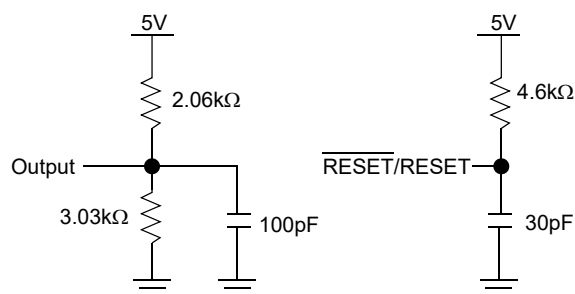
**D.C. OPERATING CHARACTERISTICS** (Over the recommended operating conditions unless otherwise specified.)

| Symbol         | Parameter                       | Limits              |      |                     | Unit | Test Conditions                                                               |
|----------------|---------------------------------|---------------------|------|---------------------|------|-------------------------------------------------------------------------------|
|                |                                 | Min.                | Typ. | Max.                |      |                                                                               |
| $I_{CC1}$      | $V_{CC}$ Write Current (Active) |                     |      | 5                   | mA   | $SCK = V_{CC} \times 0.1/V_{CC} \times 0.9$ @ 2MHz,<br>SO = Open              |
| $I_{CC2}$      | $V_{CC}$ Read Current (Active)  |                     |      | 0.4                 | mA   | $SCK = V_{CC} \times 0.1/V_{CC} \times 0.9$ @ 2MHz,<br>SO = Open              |
| $I_{SB}$       | $V_{CC}$ Standby Current        |                     |      | 1                   | μA   | $\overline{CS} = V_{CC}$ ; $V_{IN} = V_{SS}$ or $V_{CC}$ ,<br>$V_{CC} = 5.5V$ |
| $I_{LI}$       | Input Leakage Current           |                     | 0.1  | 10                  | μA   | $V_{IN} = V_{SS}$ to $V_{CC}$                                                 |
| $I_{LO}$       | Output Leakage Current          |                     | 0.1  | 10                  | μA   | $V_{OUT} = V_{SS}$ to $V_{CC}$                                                |
| $V_{IL}^{(1)}$ | Input LOW Voltage               | -0.5                |      | $V_{CC} \times 0.3$ | V    |                                                                               |
| $V_{IH}^{(1)}$ | Input HIGH Voltage              | $V_{CC} \times 0.7$ |      | $V_{CC} + 0.5$      | V    |                                                                               |
| $V_{OL1}$      | Output LOW Voltage              |                     |      | 0.4                 | V    | $V_{CC} > 3.3V$ , $I_{OL} = 2.1mA$                                            |
| $V_{OL2}$      | Output LOW Voltage              |                     |      | 0.4                 | V    | $2V < V_{CC} \leq 3.3V$ , $I_{OL} = 1mA$                                      |
| $V_{OL3}$      | Output LOW Voltage              |                     |      | 0.4                 | V    | $V_{CC} \leq 2V$ , $I_{OL} = 0.5mA$                                           |
| $V_{OH1}$      | Output HIGH Voltage             | $V_{CC} - 0.8$      |      |                     | V    | $V_{CC} > 3.3V$ , $I_{OH} = -1.0mA$                                           |
| $V_{OH2}$      | Output HIGH Voltage             | $V_{CC} - 0.4$      |      |                     | V    | $2V < V_{CC} \leq 3.3V$ , $I_{OH} = -0.4mA$                                   |
| $V_{OH3}$      | Output HIGH Voltage             | $V_{CC} - 0.2$      |      |                     | V    | $V_{CC} \leq 2V$ , $I_{OH} = -0.25mA$                                         |
| $V_{OLS}$      | Reset Output LOW Voltage        |                     |      | 0.4                 | V    | $I_{OL} = 1mA$                                                                |

**CAPACITANCE**  $T_A = +25^\circ C$ ,  $f = 1MHz$ ,  $V_{CC} = 5V$ 

| Symbol          | Test                                                            | Max. | Unit | Conditions     |
|-----------------|-----------------------------------------------------------------|------|------|----------------|
| $C_{OUT}^{(2)}$ | Output Capacitance (SO, RESET, RESET)                           | 8    | pF   | $V_{OUT} = 0V$ |
| $C_{IN}^{(2)}$  | Input Capacitance (SCK, SI, $\overline{CS}$ , $\overline{WP}$ ) | 6    | pF   | $V_{IN} = 0V$  |

Notes: (1)  $V_{IL}$  min. and  $V_{IH}$  max. are for reference only and are not tested.  
 (2) This parameter is periodically sampled and not 100% tested.

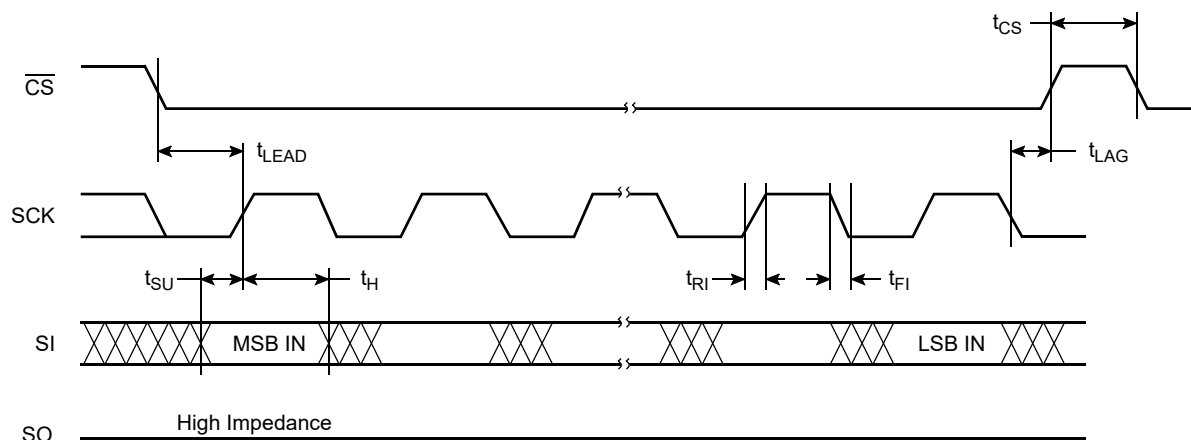
**EQUIVALENT A.C. LOAD CIRCUIT AT 5V  $V_{CC}$** **A.C. TEST CONDITIONS**

|                               |                                            |
|-------------------------------|--------------------------------------------|
| Input pulse levels            | $V_{CC} \times 0.1$ to $V_{CC} \times 0.9$ |
| Input rise and fall times     | 10ns                                       |
| Input and output timing level | $V_{CC} \times 0.5$                        |

**A.C. CHARACTERISTICS** (Over recommended operating conditions, unless otherwise specified)**Serial Input Timing**

| Symbol         | Parameter                     | 2.7-5.5V |      | Unit |
|----------------|-------------------------------|----------|------|------|
|                |                               | Min.     | Max. |      |
| $f_{SCK}$      | Clock Frequency               | 0        | 2    | MHz  |
| $t_{CYC}$      | Cycle Time                    | 500      |      | ns   |
| $t_{LEAD}$     | $\overline{CS}$ Lead Time     | 250      |      | ns   |
| $t_{LAG}$      | $\overline{CS}$ Lag Time      | 250      |      | ns   |
| $t_{WH}$       | Clock HIGH Time               | 200      |      | ns   |
| $t_{WL}$       | Clock LOW Time                | 250      |      | ns   |
| $t_{SU}$       | Data Setup Time               | 50       |      | ns   |
| $t_H$          | Data Hold Time                | 50       |      | ns   |
| $t_{RI}^{(3)}$ | Input Rise Time               |          | 100  | ns   |
| $t_{FI}^{(3)}$ | Input Fall Time               |          | 100  | ns   |
| $t_{CS}$       | $\overline{CS}$ Deselect Time | 500      |      | ns   |
| $t_{WC}^{(4)}$ | Write Cycle Time              |          | 10   | ms   |

## Serial Input Timing



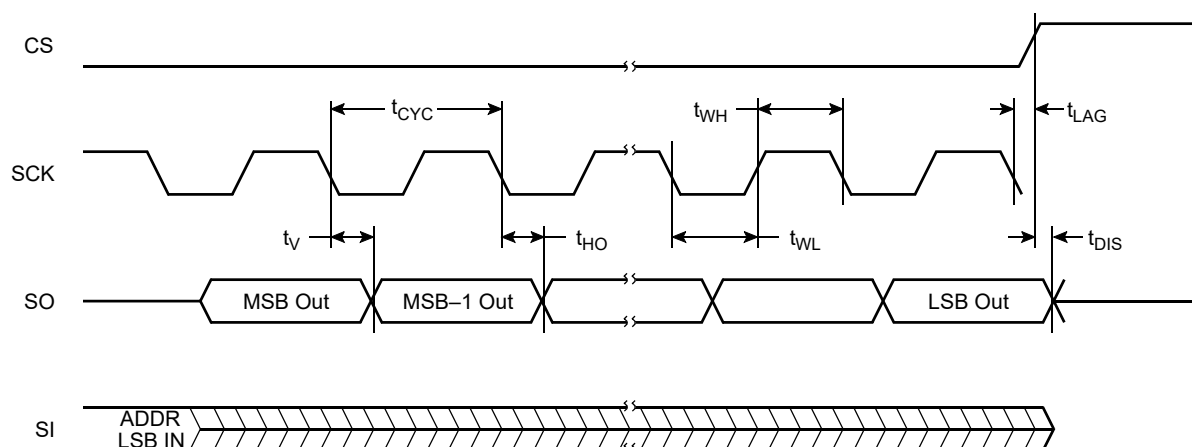
## Serial Output Timing

| Symbol         | Parameter                   | 2.7-5.5V |      | Unit |
|----------------|-----------------------------|----------|------|------|
|                |                             | Min.     | Max. |      |
| $f_{SCK}$      | Clock Frequency             | 0        | 2    | MHz  |
| $t_{DIS}$      | Output Disable Time         |          | 250  | ns   |
| $t_V$          | Output Valid from Clock Low |          | 250  | ns   |
| $t_{HO}$       | Output Hold Time            | 0        |      | ns   |
| $t_{RO}^{(3)}$ | Output Rise Time            |          | 100  | ns   |
| $t_{FO}^{(3)}$ | Output Fall Time            |          | 100  | ns   |

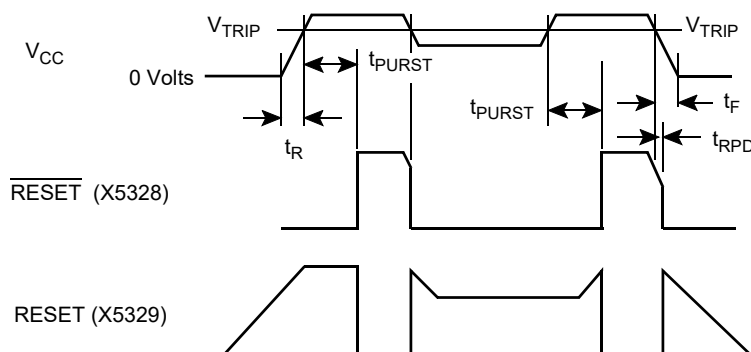
Notes: (3) This parameter is periodically sampled and not 100% tested.

(4)  $t_{WC}$  is the time from the rising edge of  $\overline{CS}$  after a valid write sequence has been sent to the end of the self-timed internal nonvolatile write cycle.

## Serial Output Timing



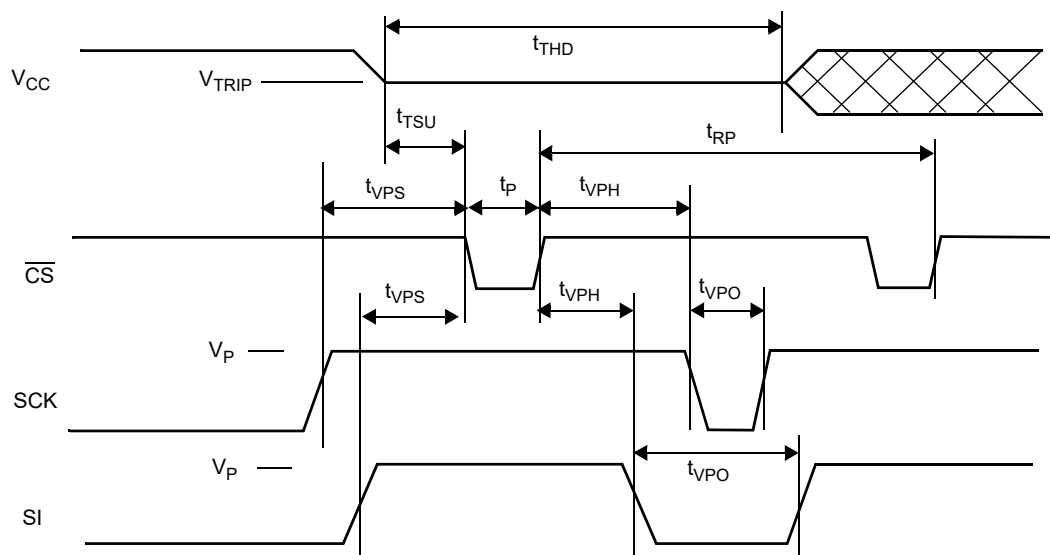
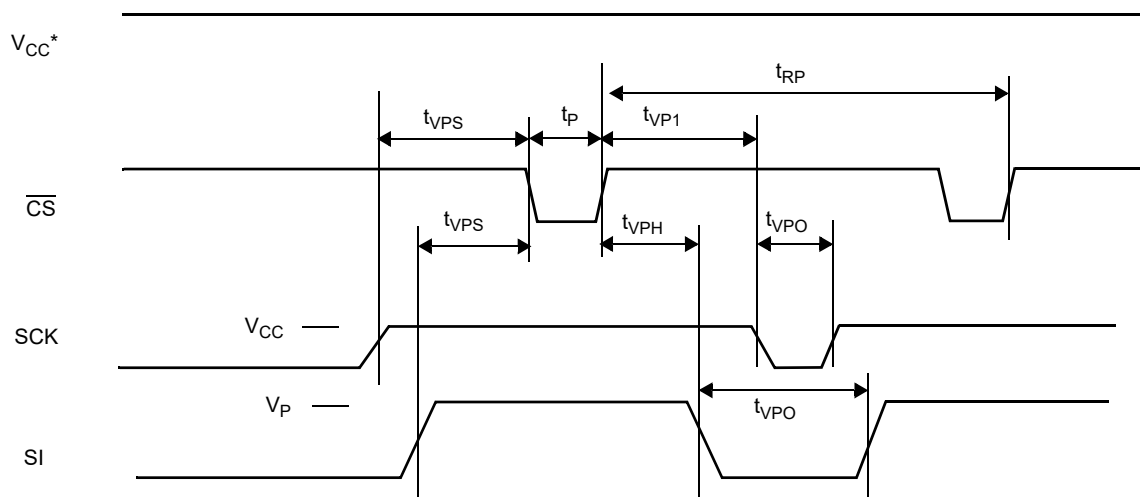
## Power-Up and Power-Down Timing



## $\overline{\text{RESET}}$ Output Timing

| Symbol          | Parameter                                                              | Min. | Typ. | Max. | Unit          |
|-----------------|------------------------------------------------------------------------|------|------|------|---------------|
| $V_{TRIP}$      | Reset Trip Point Voltage, X5328-4.5A, X5328-4.5A                       | 4.5  | 4.63 | 4.75 | V             |
|                 | Reset Trip Point Voltage, X5328, X5329                                 | 4.25 | 4.38 | 4.5  |               |
|                 | Reset Trip Point Voltage, X5328-2.7A, X5329-2.7A                       | 2.85 | 2.93 | 3.0  |               |
|                 | Reset Trip Point Voltage, X5328-2.7, X5329-2.7                         | 2.55 | 2.63 | 2.7  |               |
| $V_{TH}$        | $V_{TRIP}$ Hysteresis (HIGH to LOW vs. LOW to HIGH $V_{TRIP}$ voltage) |      | 20   |      | mV            |
| $t_{PURST}$     | Power-up Reset Time Out                                                | 100  | 200  | 280  | ms            |
| $t_{RPD}^{(5)}$ | $V_{CC}$ Detect to Reset/Output                                        |      |      | 500  | ns            |
| $t_F^{(5)}$     | $V_{CC}$ Fall Time                                                     | 100  |      |      | $\mu\text{s}$ |
| $t_R^{(5)}$     | $V_{CC}$ Rise Time                                                     | 100  |      |      | $\mu\text{s}$ |
| $V_{RVALID}$    | Reset Valid $V_{CC}$                                                   | 1    |      |      | V             |

Note: (5) This parameter is periodically sampled and not 100% tested.

**V<sub>TRIP</sub> Set Conditions****V<sub>TRIP</sub> Reset Conditions**

\*V<sub>CC</sub> > Programmed V<sub>TRIP</sub>

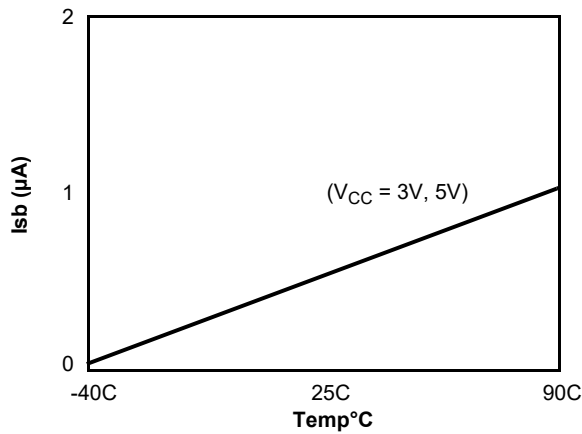
**V<sub>TRIP</sub> Programming Specifications** V<sub>CC</sub> = 1.7-5.5V; Temperature = 0°C to 70°C

| Parameter         | Description                                                                                                                                  | Min. | Max. | Unit |
|-------------------|----------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|
| t <sub>VPS</sub>  | SCK V <sub>TRIP</sub> Program Voltage Setup time                                                                                             | 1    |      | μs   |
| t <sub>VPH</sub>  | SCK V <sub>TRIP</sub> Program Voltage Hold time                                                                                              | 1    |      | μs   |
| t <sub>P</sub>    | V <sub>TRIP</sub> Program Pulse Width                                                                                                        | 1    |      | μs   |
| t <sub>TSU</sub>  | V <sub>TRIP</sub> Level Setup time                                                                                                           | 10   |      | μs   |
| t <sub>THD</sub>  | V <sub>TRIP</sub> Level Hold (stable) time                                                                                                   | 10   |      | ms   |
| t <sub>WC</sub>   | V <sub>TRIP</sub> Write Cycle Time                                                                                                           |      | 10   | ms   |
| t <sub>RP</sub>   | V <sub>TRIP</sub> Program Cycle Recovery Period (Between successive programming cycles)                                                      | 10   |      | ms   |
| t <sub>VPO</sub>  | SCK V <sub>TRIP</sub> Program Voltage Off time before next cycle                                                                             | 0    |      | ms   |
| V <sub>P</sub>    | Programming Voltage                                                                                                                          | 15   | 18   | V    |
| V <sub>TRAN</sub> | V <sub>TRIP</sub> Programed Voltage Range                                                                                                    | 1.7  | 5.0  | V    |
| V <sub>ta1</sub>  | Initial V <sub>TRIP</sub> Program Voltage accuracy (V <sub>CC</sub> applied-V <sub>TRIP</sub> ) (Programmed at 25°C.)                        | -0.1 | +0.4 | V    |
| V <sub>ta2</sub>  | Subsequent V <sub>TRIP</sub> Program Voltage accuracy [(V <sub>CC</sub> applied-V <sub>ta1</sub> )-V <sub>TRIP</sub> ] (Programmed at 25°C.) | -25  | +25  | mV   |
| V <sub>tr</sub>   | V <sub>TRIP</sub> Program Voltage repeatability (Successive program operations.) (programmed at 25°C)                                        | -25  | +25  | mV   |
| V <sub>tv</sub>   | V <sub>TRIP</sub> Program variation after programming (0-75°C). (programmed at 25°C)                                                         | -25  | +25  | mV   |

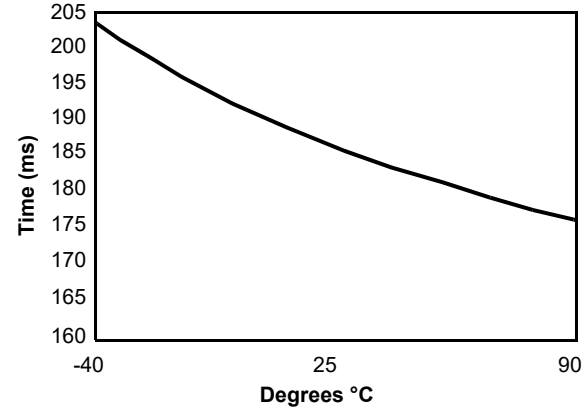
V<sub>TRIP</sub> programming parameters are periodically sampled and are not 100% tested.

TYPICAL PERFORMANCE

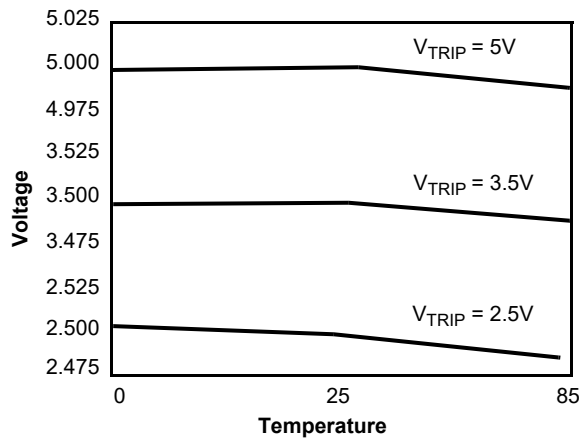
V<sub>CC</sub> Supply Current vs. Temperature (I<sub>SB</sub>)



t<sub>PURST</sub> vs. Temperature



V<sub>TRIP</sub> vs. Temperature (programmed at 25°C)



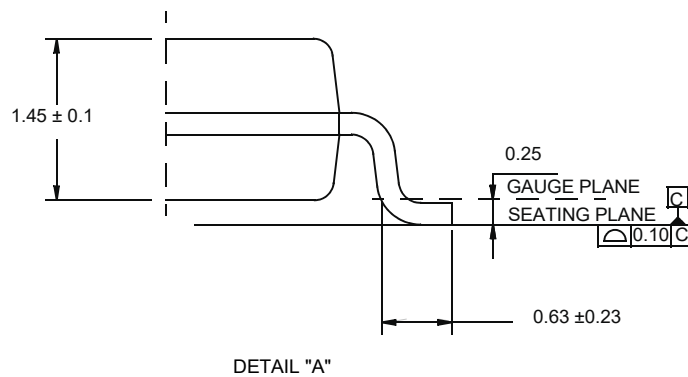
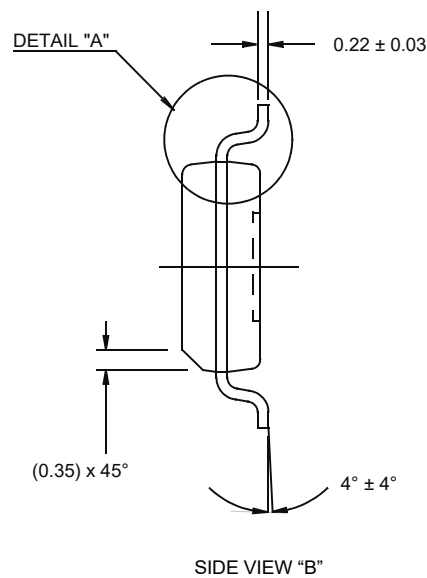
Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to the web to make sure that you have the latest revision.

| DATE         | REVISION | CHANGE                                                                                                                                                                           |
|--------------|----------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Nov 11, 2021 | 3.00     | Removed About Intersil section.<br>Removed TSSOP and PDIP information from document.<br>Updated Pin Configuration.<br>Updated Ordering information table formatting.             |
| Oct16, 2015  | 2.00     | Updated the Ordering Information table on page 2.<br>Added Revision History and About Intersil sections.<br>Replaced all Package Outline drawings with the most recent versions. |

M8.15E

Rev 0, 08/09



1. Dimensions are in millimeters.  
Dimensions in ( ) for Reference Only.
2. Dimensioning and tolerancing conform to AMSE Y14.5m-1994.
3. Unless otherwise specified, tolerance : Decimal  $\pm 0.05$
4. Dimension does not include interlead flash or protrusions.  
Interlead flash or protrusions shall not exceed 0.25mm per side.
5. The pin #1 identifier may be either a mold or mark feature.
6. Reference to JEDEC MS-012.

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(Rev.1.0 Mar 2020)

### Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu,  
Koto-ku, Tokyo 135-0061, Japan  
[www.renesas.com](http://www.renesas.com)

### Contact Information

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